## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TOIYAMA, SEIGI | Examiner | Art Unit | Darren W. Gorman | 3752 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,157,967	10-1992	Wieczorek, David P.	73/119A
*	В	US-5,241,858	09-1993	Wieczorek et al.	73/119A
*	Ċ	US-5,383,606	01-1995	Stegmaier et al.	239/575
*	D	US-6,409,094	06-2002	Tojo et al.	239/5
*	E	US-2003/0094514	05-2003	Luft, Heinz	239/533.9
*	F	US-2004/0011898	01-2004	Luft, Heinz	239/585.1
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 4211723 A1	04-1993	Germany	REITER et al.	B23P 13/00
	0	DE 19516513 A1	11-1996	Germany	SCHOEFFEL et al.	F02M 51/06
	Р					
	Q					
	R					
	s	_				
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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